18 (N) 10/661,100 **PATENT**

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Gurtej S. Sandhu et al. icant: Examiner: Unknown erial No.: 10/661,100 Group Art Unit: 2811

Filed: September 12, 2003 Docket: 303.869US1 Title: MASKING STRUCTURE HAVING MULTIPLE LAYERS INCLUDING AN

AMORPHOUS CARBON LAYER

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

In compliance with the duty imposed by 37 C.F.R. § 1.56, and in accordance with 37 C.F.R. §§ 1.97 et. seq., the enclosed materials are brought to the attention of the Examiner for consideration in connection with the above-identified patent application. Applicants respectfully request that this Supplemental Information Disclosure Statement be entered and the documents listed on the attached Form 1449 be considered by the Examiner and made of record. Pursuant to the provisions of MPEP 609, Applicants request that a copy of the 1449 form, initialed as being considered by the Examiner, be returned to the Applicants with the next official communication.

The attached documents were discovered as a result of a Search Report in Applicants' corresponding foreign patent application. Enclosed for the Examiner's information is a copy of the cited documents and the Search Report.

Pursuant to 37 C.F.R. §1.97(b), it is believed that no fee or statement is required with the Supplemental Information Disclosure Statement. However, if an Office Action on the merits has been mailed, the Commissioner is hereby authorized to charge the required fees to Deposit Account No. 19-0743 in order to have this Supplemental Information Disclosure Statement considered.

Serial No :10/661,100

Filing Date: September 12, 2003

Title: MASKING STRUCTURE HAVING MULTIPLE LAYERS INCLUDING AN AMORPHOUS CARBON LAYER

The Examiner is invited to contact the Applicants' Representative at the below-listed telephone number if there are any questions regarding this communication.

Pursuant to 37 C.F.R. 1.98(a)(2), Applicant believes that copies of cited U.S. Patents and Published Applications are no longer required to be provided to the Office. Notification of this change was provided in the United States Patent and Trademark Office OG Notices dated October 12, 2004. Thus, Applicant has not included copies of any US Patents or Published Applications cited with this submission. Should the Office require copies to be provided, Applicant respectfully requests that notice of such requirement be directed to Applicant's below-signed representative. Applicant acknowledges the requirement to submit copies of foreign patent documents and non-patent literature in accordance with 37 C.F.R. 1.98(a)(2).

Respectfully submitted, GURTEJ S. SANDHU ET AL.

By their Representatives, SCHWEGMAN, LUNDBERG, WOESSNER & KLUTH, P.A. P.O. Box 2938 Minneapolis, MN 55402 (612) 373-6969

Date th. 24 2005

Viet V. Tong

Reg. No. 45,416

CERTIFICATE UNDER 37 CFR 1.8: The undersigned hereby certifies that this correspondence is being deposited with the United States Postal Service with sufficient postage as first class mail, in an envelope addressed to: MS Amendment, Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on this 25 day of February, 2005.

Name

Signature



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Gurtej S. Sandhu et al.

Title: MASKING STRUCTURE HAVING MULTIPLE LAYERS INCLUDING AN AMORPHOUS

CARBON LAYER

Docket No.: 303.869US1 Serial No.: 10/661,100

Filed: September 12, 2003 Due Date: N/A

Examiner: Unknown Group Art Unit: 2811

Mail Stop Amendment

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

We are transmitting herewith the following attached items (as indicated with an "X"):

 \underline{X} A return postcard.

- X A Supplemental Information Disclosure Statement (2 pgs.), Form 1449 (1 pg.), and copies of 7 cited documents.
- X Copy of International Search Report and Written Opinion from corresponding forigen Application No. PCT/US2004/029209 (15 pgs.).

Please charge any additional fees or credit overpayment to Deposit Account No. 19-0743.

SCHWEGMAN, LUNDBERG, WOESSNER & KLUTH, P.A.

Customer Number 21186

Atty: Viet V. Tong

Reg. No. 45,416

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Name

Signature

SCHWEGMAN, LUNDBERG, WOESSNER & KLUTH, P.A.

(GENERAL)

Substitute for form 1449A/PTO	Complete if Known		
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Application Number	10/661,100	
(Use as many sheets as necessary)	Filing Date	September 12, 2003	
6	First Named Inventor	Sandhu, Gurtej	
FEB 2 9 2005	Group Art Unit	2811	
150 80	Filing Date September 12, 2003 First Named Inventor Sandhu, Gurtej Group Art Unit Examiner Name Unknown		
Sheet 1 of 1	Attorney Docket No: 3	03.869US1	

	US PATENT DOCUMENTS						
Examiner Initial *	USP Document Number	Publication Date	Name of Patentee or Applicant of cited Document	Filing Date If Appropriate			
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	US-2002/0001778A1	01/03/2002	Latchford, I, et al.	08/02/2001			
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	EP-1154468A2	11/14/2001	Fairbairn, K., et al.	
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	WO-03038875A2	05/08/2003	Czech, G, et al.	
	WO-2004/012246A2	02/05/2004	Bonser, D. J., et al.	

	ОТ	HER DOCUMENTS NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²
		"International Search Report and the Written Opinion of the International Searching Authority, or the Declaration for Application No. PCT/US2004/029209, date mailed December 22, 2004", 15 pages	
		LIU, W., et al., "Generating Sub-30nm Poly-Silicon Gates Using PECVD Amorphous Carbon as Hardmask and Anti-Reflective Coating", <u>Proceedings of the SPIE, 5040</u> , Optical Microlithography XVI, Yen, A, (ed.),(02/25/2003),841-848	
		SHIEH, J, et al., "Characteristics of Fluorinated Amorphous Carbon Films and Implementation of 0.15 micron Cu/a-C:F Damascene Interconnection", <u>Journal of Vacuum Science and Technology</u> , 19, (May, 2001),780-787	

EXAMINER DATE CONSIDERED